Application/Control No.	Applicant(s)/Patent under Reexamination		
10/664,623	ZIMMER ET AL.		
Examiner	Art Unit		
David E. Martinez	2181		

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East see attached	12/26/2006	DM	
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	12/26/2006	DM	
eDan Inventor search	12/26/2006	DM	
710/8-10,15-19,100,300-304.ccls. with keywords and text search	12/26/2006	DM	